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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 10/624,340
Confirmation No. 6987
Filing Date July 21, 2003
Inventor Brent A. McClure
Assignee Micron Technology, Inc.
Group Art Unit 2831
Examiner N. Ha
Attorney's Docket No. MI22-2067
Customer No. 021567
Title: Capacitor Constructions and Methods of Forming

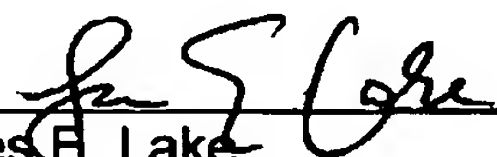
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**References – See Attached Form PTO-1449**

The Examiner's attention is directed to the references which are listed on the attached Form PTO-1449. Pursuant to 37 C.F.R. §1.98(a)(2)(1) no copies of any cited U.S. patents or U.S. published applications are included herewith. Copies of all other cited art references, if any, are attached. No admission is made regarding whether all the submitted references are prior art.

Citation of the referenced art is respectfully requested.

Respectfully submitted,

Dated: 30 Jun 2005

By: 
James E. Lake
Reg. No. 44,854

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2067		SERIAL NO. 10/624,340	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Brent A. McClure et al.			
				FILING DATE July 21, 2003		GROUP 2831	
U.S. PATENT DOCUMENTS							
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	5,908,947	06/1999	Vaartstra			
	AB	6,359,295 B2	03/2002	Yang et al.			
	AC	6,596,602 B2	07/2003	Lizuka et al.			
	AD	6,627,462 B1	09/2003	Yang et al.			
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	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
	AJ	KR 2002046433	05/2003	Lee, J.W.			
	AK	EP 1 508 906 A2	02/2005	Lee et al.			
	AL						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AM						
	AN						
	AO						
EXAMINER		DATE CONSIDERED					
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							